

Notice of References Cited	Application/Control No. 10/790,220	Applicant(s)/Patent Under Reexamination OKAZAKI ET AL.	
	Examiner Richard H. Kim	Art Unit 2871	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	C	US-6,540,361 b1	04-2003	Hayashi, Kohtaro	353/31
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NON-PATENT DOCUMENTS

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